

# Search Notes



Application/Control No.

10/661,051

Examiner

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Applicant(s)/Patent under Reexamination

GALLAGHER ET AL.

Art Unit

1765

## SEARCHED

Class	Subclass	Date	Examiner
438	694	7-12-05	K-CC
	706		
	712		
	714		
	723		
	725		
	745		
438	756	7-12-05	K-CC

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East key word search USPAT, USPG-Pub Ept, JPO, Derwent IBM-TDB	7-12-05	K-CC
inventor search	7-12-05	K-CC